SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

•	Full Look Ahead for High-Speed Operations
	on Long Words

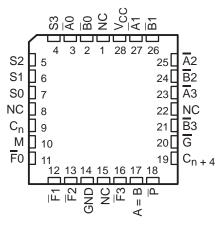
- Arithmetic Operating Modes:
- Addition
- Subtraction
- Shift Operand A One Position
- Magnitude Comparison
- Twelve Other Arithmetic Operations
- Logic Function Modes:
 - Exclusive-OR
 - Comparator
 - AND, NAND, OR, NOR
- Package Options Include Plastic Small-Outline (N) Packages, Ceramic (FK) Chip Carriers, Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs, and Ceramic (JW) 600-mil DIPs

description

The SN54AS181B and SN74AS181A arithmetic logic units (ALUs)/function generators have a complexity of 75 equivalent gates on a monolithic chip. These circuits perform 16 binary arithmetic operations on two 4-bit words as shown in Tables 1 and 2. These operations are selected by the four function-select (S0, S1, S2, and S3) lines and include addition, subtraction, decrement, and straight transfer. When performing arithmetic manipulations, the internal carries are enabled by applying a low-level voltage to the mode-control (M) input. A full carry look-ahead scheme is used to generate fast, simultaneous carry by means of two cascade (\overline{G} and \overline{P}) outputs for the four bits in the package.

SN54AS181B JT OR JW PACKAGE SN74AS181A N OR NT PACKAGE (TOP VIEW)										
B0	1	24] V _{CC}							
A0	2	23] A1							
S3	3	22] B1							
S1	4	21] A2							
S0	5	20] B2							
Cn	6	19] A3							
F0	7	18] B3							
F0	8	17] G							
F1	9	16] C _n + 4							
S0	10	15] P							
GND	11	14] A = B							
GND	12	13] F3							

SN54AS181B . . . FK PACKAGE (TOP VIEW)





If high speed is not important, a ripple-carry (C_n) input and a ripple-carry ($C_{n + 4}$) output are available. The ripple-carry delay is minimized so that arithmetic manipulations for small word lengths can be performed without external circuitry.

The SN54AS181B and SN74AS181A accommodate active-high or active-low data if the pin designations are interpreted as follows:

PIN NUMBER	2	1	23	22	21	20	19	18	9	10	11	13	7	16	15	17
Active-low data (Table 1)	A0	B0	A1	B1	A2	B2	A3	B3	F0	F1	F2	F3	Cn	C _{n + 4}	Ρ	G
Active-high data (Table 2)	A0	B0	A1	B1	A2	B2	A3	B3	F0	F1	F2	F3	Cn	\overline{C}_{n+4}	Х	Y

Subtraction is accomplished by 1's complement addition where the 1's complement of the subtrahend is generated internally. The resultant output is A-B-1, which requires an end-around or forced carry to provide A-B.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

description (continued)

The SN54AS181B and SN74AS181A also can be used as comparators. The A = B output is internally decoded from the function (F0, F1, F2, F3) outputs so that when two words of equal magnitude are applied at the A and B inputs, the output assumes a high level to indicate equality (A = B). The ALU must be in the subtract mode with $C_n = H$ when performing this comparison. The A = B output is open collector so that it can be wire-AND connected to give a comparison for more than four bits. $C_{n + 4}$ also can be used to supply relative magnitude information. The ALU must be placed in the subtract mode by placing the function-select inputs S3, S2, S1, and S0 at L, H, H, and L, respectively.

INPUT C _n	OUTPUT C _{n + 4}	ACTIVE-LOW DATA (Figure 1)	ACTIVE-HIGH DATA (Figure 2)
Н	Н	$A \ge B$	$A \leq B$
н	L	A < B	A > B
L	Н	A > B	A < B
L	L	$A \leq B$	$A \ge B$

These circuits not only incorporate all of the designer's requirements for arithmetic operations, but also provide 16 possible functions of two Boolean variables without using external circuitry. These logic functions are selected by the four function-select inputs with M at a high level to disable the internal carry. The 16 logic functions are detailed in Tables 1 and 2 and include exclusive-OR, NAND, AND, NOR, and OR functions.

(CL = 13 pr, KL = 200 22, TA = 23 C)												
	ADDITION	PACK	AGE COUNT									
NUMBER OF BITS	TIME USING 'S181 AND 'S182	ALUs	LOOK-AHEAD CARRY GENERATORS	CARRY METHOD BETWEEN ALUS								
1 to 4	11 ns	1		None								
5 to 8	18 ns	2		Ripple								
9 to 16	19 ns	3 or 4	1	Full look ahead								
17 to 64	28 ns	5 to 16	2 to 5	Full look ahead								

TYPICAL ADDITION TIME (C₁ = 15 pF. R₁ = 280 Ω , T₄ = 25°C)

The SN54AS181B is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74AS181A is characterized for operation from 0° C to 70° C.

application note

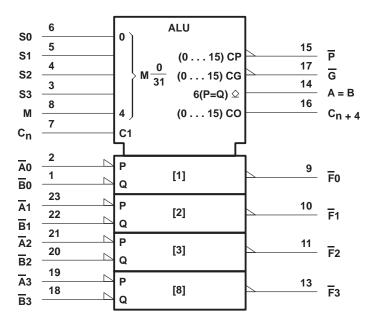
An application-specific problem has been identified in the SN54AS181B device. The F0–F4 outputs exhibit voltage transients when one or more B-data inputs transition from a high to a low state. The resultant voltage transients can have an amplitude of 2 V relative to V_{OL} with a width of 5 ns at an input threshold of 1.5 V. The transient pulse occurs coincidentally with the high-to-low transition of the B-data input(s) and appears to be caused by internal coupling.

In system operations in which this device is used, it is likely that transmission-line effects minimize this anomaly. Narrow width of the voltage transient makes the pulse transparent to most circuitry; however, in certain applications, the transients can cause system errors.



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

logic symbol[†]

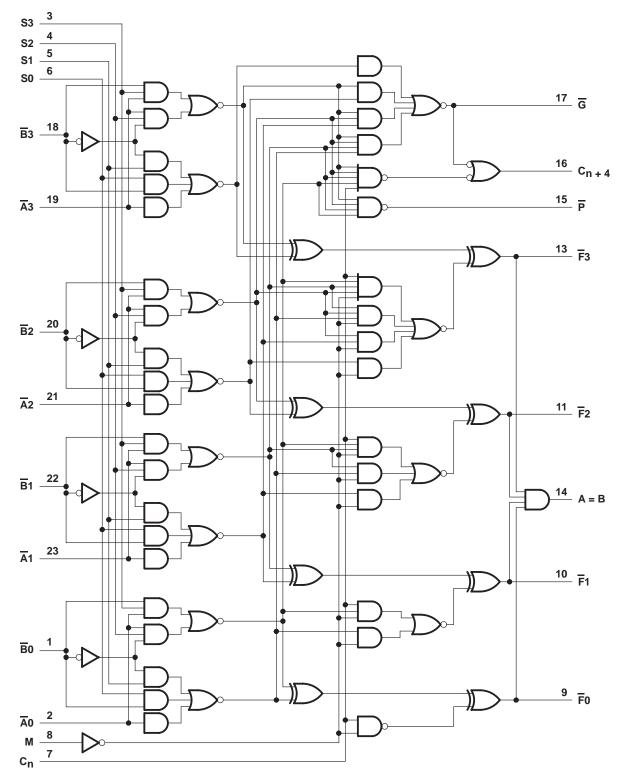


 † This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the JT, JW, N, and NT packages.



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

logic diagram



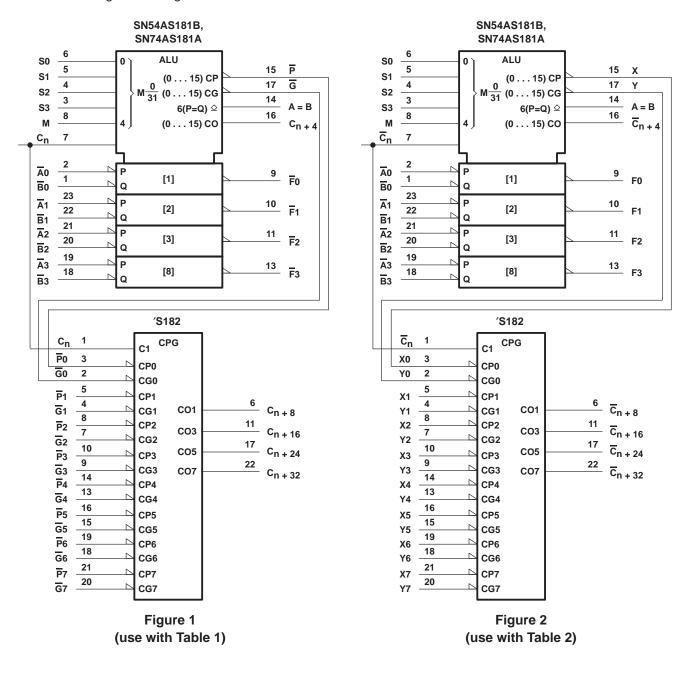
Pin numbers shown are for the JT, JW, N, and NT packages.



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

signal designations

In Figures 1 and 2, the polarity indicators (rightarrow) indicate that the associated input or output is active low with respect to the function shown inside the symbol. The symbols are the same in both figures. The signal designations in Figure 1 agree with the indicated internal functions based on active-low data and are for use with the logic functions and arithmetic operations shown in Table 1. The signal designations have been changed in Figure 2 to accommodate the logic functions and arithmetic operations for the active-high data given in Table 2. The SN54AS181B and SN74AS181A together with the 'S182 can be used with the signal designation of either Figure 1 or Figure 2.





SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

					Table 1					
	SELE				ACTIVE-LOW DA	ATA				
	SELE	STION		M = H	M = L; ARITHMETIC OPERATIONS					
S3	S2	S 1	S0	LOGIC FUNCTIONS	C _n = L (no carry)	C _n = H (with carry)				
L	L	L	L	$F = \overline{A}$	F = A MINUS 1	F = A				
L	L	L	Н	$F = \overline{AB}$	F = AB MINUS 1	F = AB				
L	L	Н	L	$F = \overline{A} + B$	F = AB MINUS 1	F = AB				
L	L	Н	Н	F = 1	F = MINUS 1 (2's COMP)	F = ZERO				
L	Н	L	L	$F = \overline{A + B}$	$F = A PLUS (A + \overline{B})$	$F = A PLUS (A + \overline{B}) PLUS 1$				
L	н	L	Н	$F = \overline{B}$	F = AB PLUS (A + B)	F = AB PLUS (A + B) PLUS 1				
L	Н	Н	L	$F = \overline{A \oplus B}$	F = A MINUS B MINUS 1	F = A MINUS B				
L	Н	Н	Н	$F = A + \overline{B}$	F = A + B	F = (A + B) PLUS 1				
н	L	L	L	$F = \overline{A}B$	F = A PLUS (A + B)	F = A PLUS (A + B) PLUS 1				
н	L	L	н	$F=A\oplusB$	F = A PLUS B	F = A PLUS B PLUS 1				
н	L	Н	L	F = B	F = AB PLUS (A + B)	F = AB PLUS (A + B) PLUS 1				
н	L	Н	Н	F = A + B	F = (A + B)	F = (A + B) PLUS 1				
н	Н	L	L	F = 0	F = A PLUS A [†]	F = A PLUS A PLUS 1				
н	Н	L	Н	$F = A\overline{B}$	F = AB PLUS A	F = AB PLUS A PLUS 1				
н	Н	Н	L	F = AB	F = AB PLUS A	F =AB PLUS A PLUS 1				
н	Н	Н	Н	F = A	F = A PLUS 1	F = A PLUS 1				

[†]Each bit is shifted to the next more significant position.

Table 2

	SELE				ACTIVE-HIGH D/	ATA			
	SELE	STION		M = H	M = L; ARITHMETIC OPERATIONS				
S3	S2	S1	S0	LOGIC FUNCTIONS	C _n = H (no carry)	C _n = L (with carry)			
L	L	L	L	$F = \overline{A}$	F = A	F = A PLUS 1			
L	L	L	Н	$F = \overline{A + B}$	F = A + B	F = (A+ B) PLUS 1			
L	L	Н	L	$F = \overline{A}B$	$F = A + \overline{B}$	$F = (A + \overline{B}) PLUS 1$			
L	L	Н	Н	F = 0	F = MINUS 1 (2's COMPL)	F = ZERO			
L	н	L	L	$F = \overline{AB}$	F = A PLUS AB	F = A PLUS AB PLUS 1			
L	Н	L	Н	$F = \overline{B}$	F = (A + B) PLUS AB	F =(A + B) PLUS AB PLUS 1			
L	Н	Н	L	$F=A\oplusB$	F = A MINUS B MINUS 1	F = A MINUS B			
L	н	Н	н	$F = A\overline{B}$	F = AB MINUS 1	$F = A \overline{B}$			
н	L	L	L	$F = \overline{A} + B$	F = A PLUS AB	F = A PLUS AB PLUS 1			
н	L	L	Н	$F = \overline{A \oplus B}$	F = A PLUS B	F = A PLUS B PLUS 1			
н	L	Н	L	F = B	$F = (A + \overline{B}) PLUS AB$	F = (A + B) PLUS AB PLUS 1			
н	L	Н	Н	F = AB	F = AB MINUS 1	F = AB			
н	Н	L	L	F = 1	F = A PLUS A [†]	F = A PLUS A PLUS 1			
н	Н	L	н	$F = A + \overline{B}$	F = (A + B) PLUS A	F = (A + B) PLUS A PLUS 1			
н	н	Н	L	F = A + B	$F = (A + \overline{B}) PLUS A$	F =(A + B) PLUS A PLUS 1			
н	Н	н	Н	F = A	F = A MINUS 1	F = A			

[†] Each bit is shifted to the next more significant position.

SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC}	
Input voltage, V _I	7V
Off-state output voltage (A = B output only)	7V
Operating free-air temperature range, T _A : SN54AS181B	
SN74AS181A	0°C to 70°C
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			SN	54AS18	1B	SN74AS181A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage				0.8			0.8	V
VOH	High-level output voltage	A = B output only			5.5			5.5	V
lau	High lovel output ourrept	All outputs except A = B and \overline{G}		-2				-2	m A
ЮН	High-level output current	G			-3			-3	mA
1		All outputs except G			20			20	A
IOL	Low-level output current	G			48			48	mA
TA	Operating free-air temperature		-55		125	0		70	°C



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CON		SN	54AS18	1B	SN	74AS18 [,]	1A	UNIT	
	PARAMETER	TEST CONI	DITIONS	MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT	
VIK		V _{CC} = 4.5 V,	lj = - 18 mA			-1.2			-1.2	V	
V	Any output except A = B	V_{CC} = 4.5 V to 5.5 V,	I _{OH} = -2 mA	V _{CC} -2	2		V _{CC} -2			V	
VOH	G	V _{CC} = 4.5 V,	$I_{OH} = -3 \text{ mA}$	2.4	3.4		2.4	3.4		V	
Ve	Any output except G		I _{OL} = 20 mA		0.3	0.5		0.3	0.5	V	
VOL	G	V _{CC} = 4.5 V	I _{OL} = 48 mA		0.4	0.5		0.4	0.5	v	
IOH	A = B	V _{CC} = 4.5 V,	V _{OH} = 5.5 V			0.1			0.1	mA	
	Μ					0.1			0.1		
. h	Any A or B		$\lambda = 7 \lambda$			0.3			0.3	mA	
I	Any S	V _{CC} = 5.5 V,	v] = 7 v			0.4			0.4	ША	
	C _n					0.6			0.6		
	Μ					20			20		
1	Any A or B			5.5 V, VI = 2.7 V			60			60	μA
ΙΗ	Any S	VCC = 5.5 V,	$v_{1} = 2.7 v_{2}$				80			80	μΑ
	Cn					120			120		
	Μ					-0.5			-2		
1	Any A or B	V _{CC} = 5.5 V,	$\lambda = 0.4 \lambda$			-1.5			-6		
۱IL	Any S	VCC = 5.5 V,	v] = 0.4 v			-2			-8	mA	
	C _n					-3			-12		
۱ ₀ ‡	All outputs except A = B and \overline{G}	V _{CC} = 5.5 V,	V _O = 2.25 V	-30	-45	-112	-30	-45	-112	mA	
-	G		0	-30		-125	-30		-125	1	
ICC		V _{CC} = 5.5 V			74	117		135	200	mA	

[†] All typical values are at V_{CC} = 5 V, $T_A = 25^{\circ}C$.

[‡]The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

switching characteristics (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS [†]	CL RL	= 50 pF = 500 Ω = MIN t			UNIT
						MIN	MAX	
^t PLH	Cn	C _{n + 4}		3	9	2	9	ns
^t PHL		°11 + 4		2	7	2	9	
^t PLH			M = 0, S1 = S2 = 0,	2	16	2	12	ns
^t PHL		-11 + 4	S0 = S3 = 4.5 V (SUM mode)	2	14	2	12	
^t PLH	Any \overline{A} or \overline{B}	C _{n + 4}	M = 0, S1 = S3 = 0,	3	18	4	16	ns
^t PHL		-11 + 4	S1 = S2 = 4.5 V (DIFF mode)	3	14.5	2	16	
^t PLH	C _n Any F		M = 0 (SUM or DIFF mode)	3	10.5	3	9	ns
^t PHL		,, ·		3	9			
^t PLH	Any A or B G	M = 0, S1 = S2 = 0,	3	9.5	2	8	ns	
^t PHL			S0 = S3 = 4.5 V (SUM mode)	2	7	2	7	
^t PLH	tPLH Any A or B	G	M = 0, S1 = S3 = 0,	3	12	2	9.5	ns
^t PHL		S1 = S2 = 4.5 V (DIFF mode)		2	9	2	9	
^t PLH	Any \overline{A} or \overline{B}	P	M = 0, S1 = S2 = 0,	3	9.5	2	8	ns
^t PHL		-	S0 = S3 = 4.5 V (SUM mode)	2	7.5	2	8	
^t PLH	Any A or B	P	M = 0, S1 = S3 = 0,	3	12	2	10	ns
^t PHL	, .		S1 = S2 = 4.5 V (DIFF mode)	3	8.5	2	10	
^t PLH	Ai or Bi	Fi	M = 0, S1 = S2 = 0,	3	11	2	9.5	ns
^t PHL			S0 = S3 = 4.5 V (SUM mode)	3	9	2	8	
^t PLH	Ai or Bi	Fi	M = 0, S1 = S3 = 0,	3	13.5	2	10.5	ns
^t PHL			S1 = S2 = 4.5 V (DIFF mode)	3	11	2	10	
^t PLH	Ai or Bi	Fi	M = 4.5 V (LOGIC mode)	3	16	2	11	ns
^t PHL		- •		3	10	2	11	
^t PLH	Any \overline{A} or \overline{B}	A = B	M = 0, S1 = S3 = 0,	2	19	4	21	ns
^t PHL	, .		S1 = S2 = 4.5 V (DIFF mode)	3	22	4	21	

[†]Refer to the parameter measurement information tables for the SUM-, DIFF-, and LOGIC-mode test tables.

[‡] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994

PARAMETER MEASUREMENT INFORMATION

PARAMETER			R INPUT IE BIT	OTHER DA	ATA INPUTS	OUTPUT	OUTPUT	
PARAMETER	UNDER TEST	APPLY 4.5 V	APPLY GND	APPLY 4.5 V	APPLY GND	UNDER TEST	WAVEFORM (See Note 1)	
^t PLH ^t PHL	Āi	Bi	None	Remaining A and B	Cn	Fi	In phase	
t _{PLH}	Bi	Āi	None	Remain <u>ing</u> A and B	C _n	Fi	In phase	
^t PLH ^t PHL	Āi	Bi	None	None	Remaining A and B, C _n	P	In phase	
tPLH tPHL	Bi	Āi	None	None	Remaining A and B, C _n	P	In phase	
tplh tphl	Āi	None	Bi	Rem <u>a</u> ining B	Remaining Ā, C _n	G	In phase	
^t PLH ^t PHL	Bi	None	Āi	Remaining B	Remaining Ā, C _n	G	In phase	
tplh tphl	Cn	None	None	All Ā	All B	Any F or C _{n + 4}	In phase	
tplh tphl	Āi	None	Bi	Rem <u>ai</u> ning B	Remaining Ā, C _n	C _{n + 4}	Out of phase	
t _{PLH}	Bi	None	Āi	Remaining B	Remaining Ā, C _n	C _{n + 4}	Out of phase	

SUM-MODE TEST TABLE (Function Inputs: S0 = S3 = 4.5 V. S1 = S2 = M = 0)



SDAS209B – DECEMBER 1982 – REVISED DECEMBER 1994

PARAMETER MEASUREMENT INFORMATION

PARAMETER		OTHER SAME		OTHER DA	ATA INPUTS		OUTPUT
	TEST	APPLY APPLY 4.5 V GND		APPLY 4.5 V	APPLY GND	TEST	WAVEFORM (See Note 1)
^t PLH ^t PHL	Āi	None	Bi	Rem <u>a</u> ining	Remaining B, C _n	Fi	In phase
^t PLH ^t PHL	Bi	Āi	None	Rem <u>a</u> ining	Remaining B, C _n	Fi	Out of phase
^t PLH ^t PHL	Āi	None Bi		None	Remaining A and B, C _n	P	In phase
^t PLH ^t PHL	Bi	Āi	None	None	Remaining A and B, C _n	P	Out of phase
^t PLH ^t PHL	Āi	Bi	None	None	Remaining A and B, C _n	G	In phase
^t PLH ^t PHL	Bi	None Ai		None	Remaining A and B, C _n	G	Out of phase
^t PLH ^t PHL	Āi	None Bi		Remaining A	Remaining B, C _n	A = B	In phase
^t PLH ^t PHL	Bi	Ai None		Rem <u>a</u> ining A	Remaining B, C _n	A = B	Out of phase
^t PLH ^t PHL	C _n	None None		All All And B	None	C _{n + 4} or any F	In phase
^t PLH ^t PHL	Āi	Bi	None	None	Remaining Ā, Ē, C _n	C _{n + 4}	Out of phase
^t PLH ^t PHL	Bi	None	Āi	None	Remaining A, B, C _n	C _{n + 4}	In phase

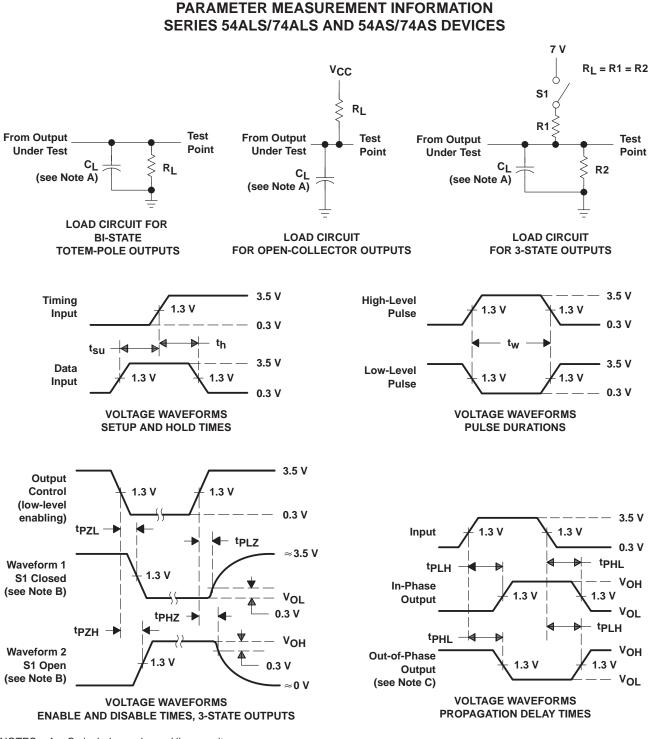
DIFF-MODE TEST TABLE (Function Inputs: S1 = S2 = 4.5 V, S0 = S3 = M = 0)

LOGIC-MODE TEST TABLE (Function Inputs: S1 = S2 = M = 4.5 V, S0 = S3 = 0)

PARAMETER		OTHER SAME	-	OTHER DA	ATA INPUTS		OUTPUT WAVEFORM	
FARAMETER	TEST	APPLY 4.5 V	APPLY GND	APPLY APPLY GND 4.5 V		TEST	(See Note 1)	
^t PLH ^t PHL	Āi	Bi	None	None	Remaining A and B, C _n	Fi	Out of phase	
^t PLH ^t PHL	Bi	Āi	None	None	Remaining A and B, C _n	Fi	Out of phase	



SDAS209B - DECEMBER 1982 - REVISED DECEMBER 1994



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, t_r = t_f = 2 ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms





11-Apr-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
SN54AS181BJT	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		
SN74AS181AN	OBSOLETE	PDIP	Ν	24		TBD	Call TI	Call TI	0 to 70		
SNJ54AS181BFK	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125		
SNJ54AS181BJT	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

MECHANICAL DATA

MCER004A - JANUARY 1995 - REVISED JANUARY 1997

JT (R-GDIP-T**)

CERAMIC DUAL-IN-LINE

24 LEADS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB



LEADLESS CERAMIC CHIP CARRIER

FK (S-CQCC-N**) 28 TERMINAL SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. This package can be hermetically sealed with a metal lid.

D. Falls within JEDEC MS-004

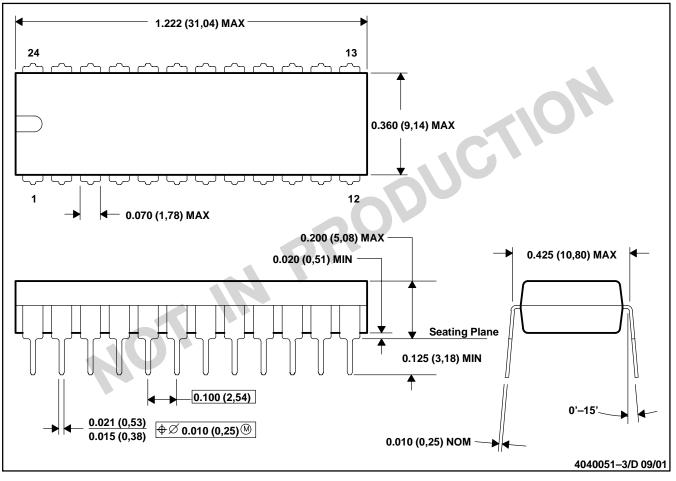


MECHANICAL DATA

MPDI006B - SEPTEMBER 2001 - REVISED APRIL 2002

N (R-PDIP-T24)

PLASTIC DUAL-IN-LINE



- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-010



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Applications Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconne	ectivity	

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2013, Texas Instruments Incorporated